

<b>Notice of References Cited</b>	Application/Control No. 10/711,354	Applicant(s)/Patent Under Reexamination GLOSSER ET AL.	
	Examiner Anthony T. Perry	Art Unit 2879	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-5,475,227	12-1995	LaRue, Ross A.	250/397
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	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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	U	A A Dowman, T H Jones and A H Beck, "Scanning Electron Diffraction Studies on Alkali Antimonide Photocathodes, Including the S20", J. Phys. D: Appl. Phys., Vol. 8, 1975, pages 69-84
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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